

**Notice of References Cited**

Application/Control No.

10/528,842

Applicant(s)/Patent Under  
Reexamination  
SCHECHNER ET AL.

Examiner

Nikki H. Dees

Art Unit

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0219388 A1	11-2003	Kropf et al.	424/50
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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	N	DE 10063945 A1	07-2002	Germany	Kropf et al.	A61 K 6/00
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	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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